Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/904,009	CARVEY, PHILIP P.	
Examiner	Art Unit	
Jay P. Patel	2666	

	SEARCHED				
Class	Subclass	Date	Examiner		
370	400	11/13/2005	JPP		
370	251	11/13/2005	JPP		
370	254	11/13/2005	JPP		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
370	400	11/13/2005	JPP	
370	251	11/13/2005	JPP	
370	254	11/13/2005	JPP	

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
370/400 with keywords (redix near diameter)	11/13/2005	JPP
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